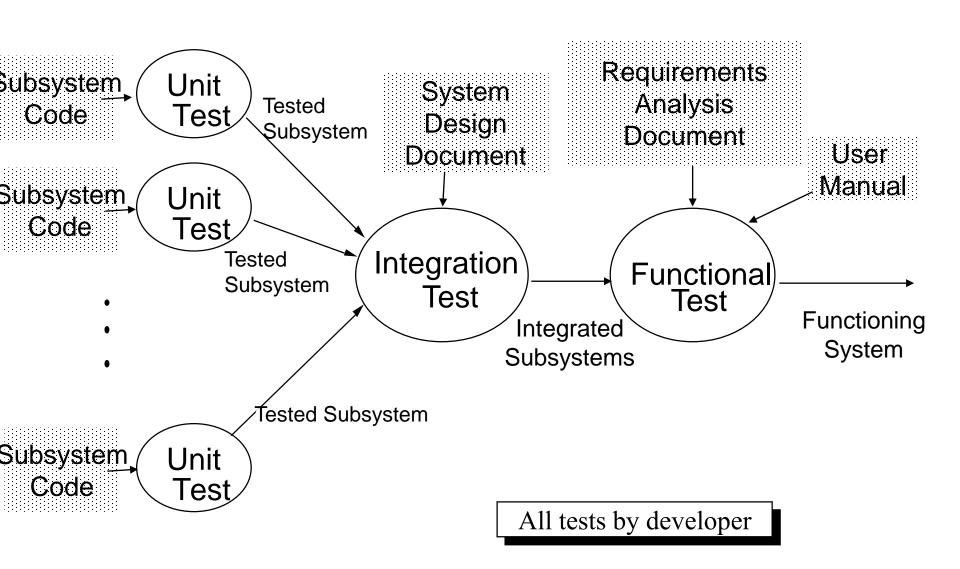
Integration Testing

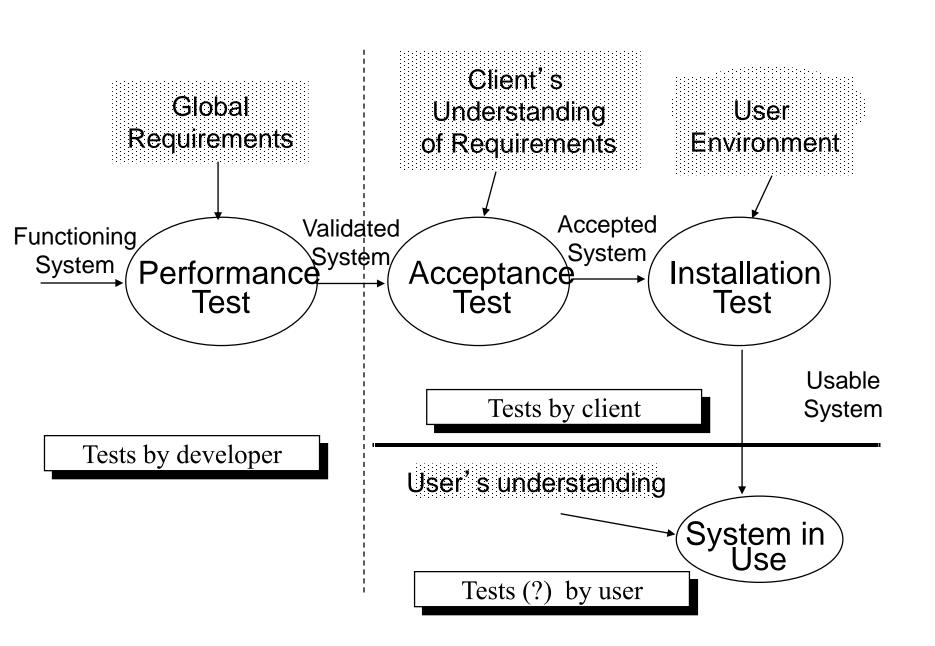


Integration Testing

 integration testing - testing in which individual software modules are combined and tested as a group.

- occurs after unit testing and before system testing.
- integration testing takes as its input modules that have been unit tested, groups them in larger aggregates, applies tests defined in an integration test plan.





Types of Testing

Unit Testing:

- □ Individual subsystem
- Carried out by developers
- Goal: Confirm that subsystems is correctly coded and carries out the intended functionality

Integration Testing:

- Groups of subsystems (collection of classes) and eventually the entire system
- Carried out by developers
- □ Goal: Test the interface among the subsystem



Recall that testing uses 50-60% of all project resources

70% of testing resources is spent on integration testing

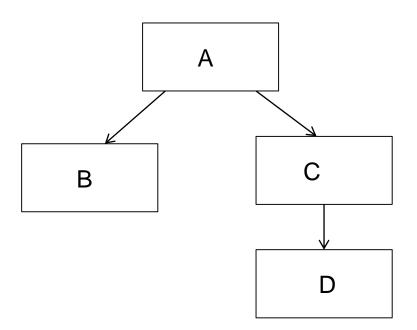
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Dependency tree

Hierarchical representation of dependencies between modules

In integration testing: **uses** dependency

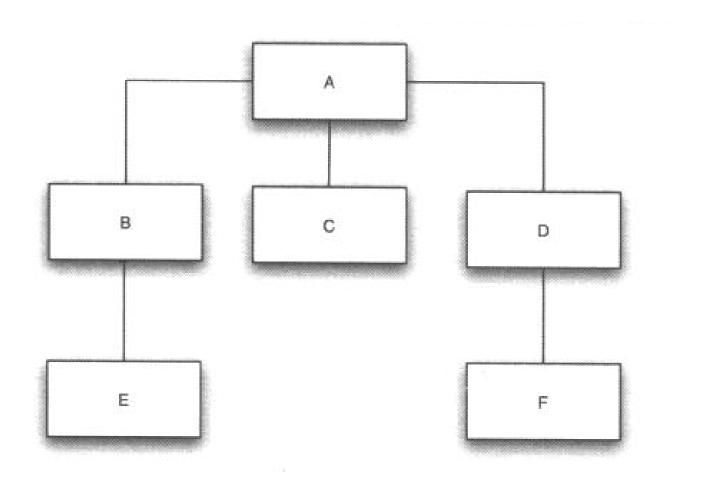
Module A uses module B == (some function in) module A calls (some function in module B)



A uses (calls) B A uses (calls) C

C uses (calls) D

Example – A hierarchy of modules



M

Interaction dependencies

Function calls (usual case)

Remote procedure calls

Communication through global data

Client-server architecture

Inheritance

Calls to an application programming interface (API)

Pointers to objects

• • •



Integration Testing

of software subsystems (modules) into a single system

Two main approaches:

- •Test each module independently, combine the modules [non-incremental, big bang testing / integration]
- •combine the next module to be tested with the set of the previously tested modules before it is tested [incremental testing / integration]

Non-incremental Integration Testing

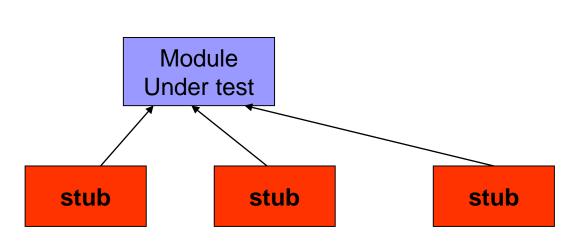


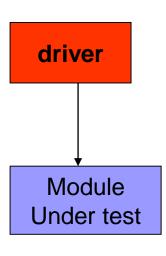
Non-incremental testing

Module testing realized for each module separately (module regarded as a stand-alone entity)

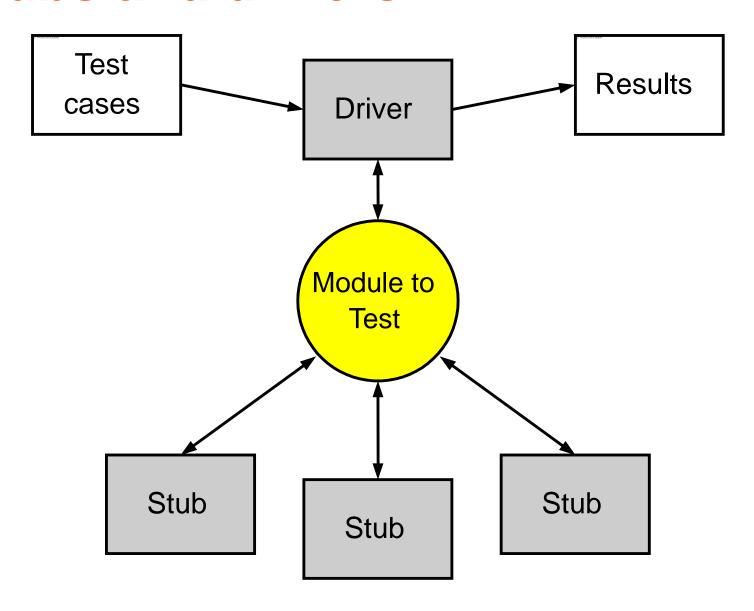
Modules could be tested at the same time or in series

Testing modules requires **STUBS** OR A **DRIVER**





Stubs and drivers



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Stubs

- Do nothing
- Validate the inputs
- Send a message to a log
- Return a hard-coded answer regardless of the input
- Select an answer from a pool of hard-coded answers
 Cycle through the pool or randomly select one
- Randomly generate an answer
- Prompt the user for the answer
- Simple implementation of the module that is slower, less accurate, or somehow less capable than the real module
- Pause for awhile to simulate the time taken by the real module

Drivers

- Invokes the module with fixed inputs
- Compares actual outputs with expected outputs
- Records failure if expected and actual outputs do not match
- Normally continues to execute even if a test case fails
- Drivers and stubs must be designed together
- Since stubs do not produce "real" outputs, the expected results in the driver must take into account the "fake" behavior of the stubs

Non-incremental (Big Bang) Testing

In Big Bang Integration testing, individual modules of the programs not integrated until **everything** is ready.

'Run it and see' approach.

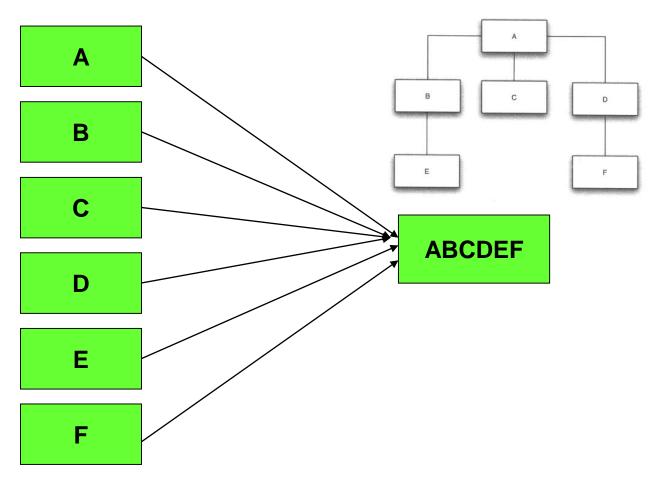
System is integrated without any formal integration testing, and then run to ensure that all the components are working properly.



Non-incremental testing

Integration realized in a single step (big bang) and system is tested as

a single entity





More opportunities for parallel activities; significance in large projects

May be the only feasible approach for a monolithic system (unstructured systems, no design, components tightly coupled)

Could be suitable for small systems

Non-incremental testing: main features

Amount of work could be large: number of stubs and drivers

Possible mismatching interfaces: modules do not "see one another" until the end of the process

Debugging could be difficult. It is difficult to tell whether defect is In the component or interface

Approach is ambiguous and opportunistic

Bottom-up Integration Testing

Bottom-up integration testing

Strategy starts with the terminal modules (that do not call other modules)

We need drivers (they are simpler than stubs and no multiple versions are needed)

There is no concept of a skeleton of the system (integration is late and time to working system is longer).

Well-suited for components with robust and stable interface

Bottom-up design methodology was used

Can provide an early assessment of a unit that must implement a critical requirement

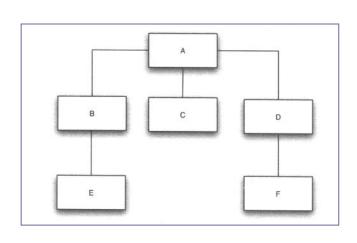
Work may proceed in parallel

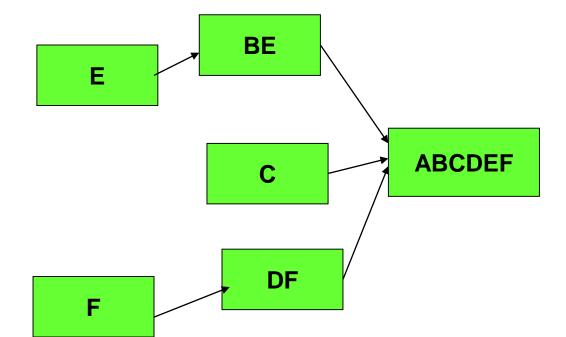
Bottom up integration testing

Bottom-up: start from the lower end and move forward

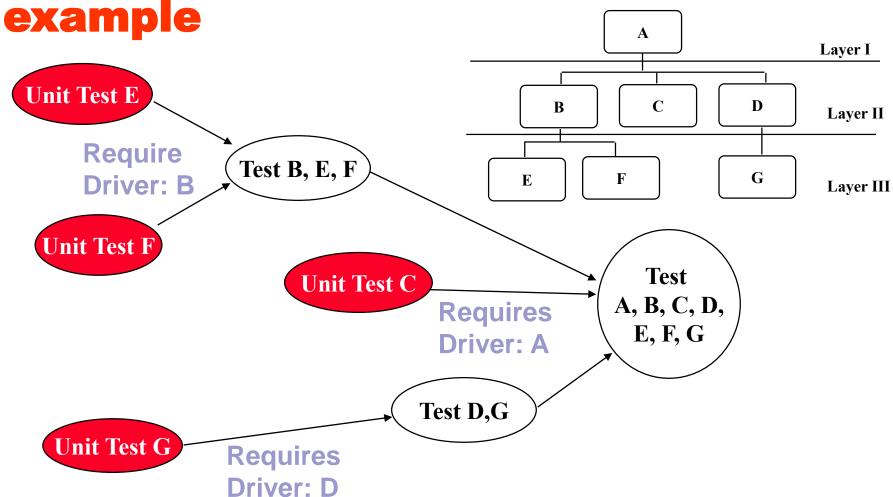
E, C, F – we need drivers here (3)

BE and DF (B and D are not tested in isolation but with E and F) we need 2 drivers





Bottom up integration testingexample





Bottom-up Integration Testing

As and when code for other module gets ready, these drivers are replaced with the actual module.

In this approach, lower level modules are tested extensively thus make sure that highest used module is tested properly.

Top-down Integration Testing

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Testing strategy

Test the top layer (or the controlling subsystem) first

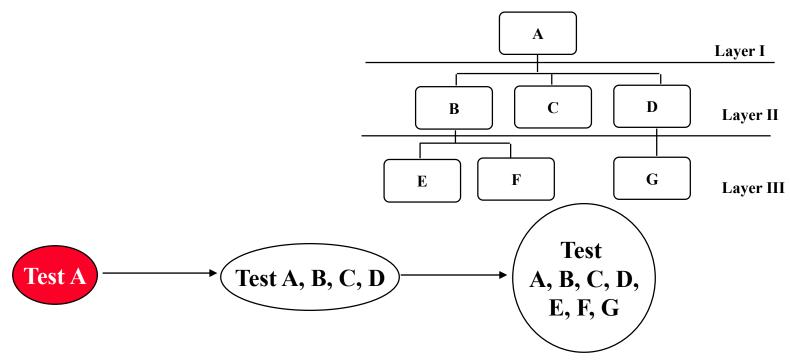
Combine all the subsystems that are called by the tested subsystems and test the resulting collection of subsystems

Do this until all subsystems are incorporated into the test

Lower level modules are normally simulated by stubs which mimic functionality of lower level modules.

As lower level code has been added, stubs are replaced with the actual components.

Example



Layer I

Layer I + II

Requires stubs:

BCD

EFG

All Layers

Top-down integration testing

Start from the top (initial module)

No single procedure to select next module to be incrementally tested

Just choose one for which one of the calling modules must have been tested previously

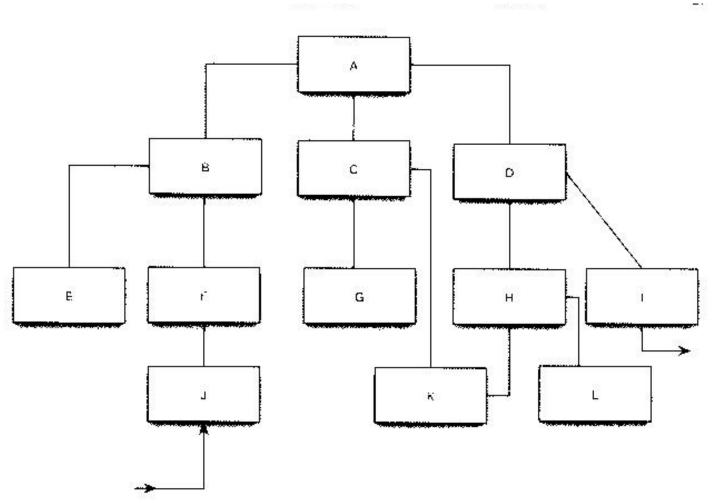
Stubs are needed for modules that are called

Avoidance of commitment to an unstable interface (lower level interfaces undefined or likely to change)

Constructing stubs is not trivial – sometimes it is misunderstood (say dummy stubs or "we got so far")

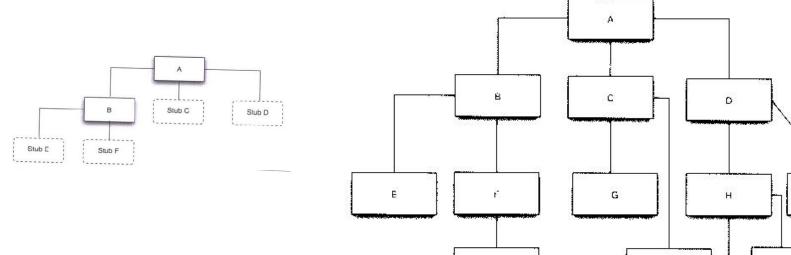
Stubs feed data to modules at the higher level; we may require multiple versions of the same stub

Top-down testing



Module J: I/O operations Module I: write operations

Top-down testing



Possible sequences of modules:

A B C D E F G H I J K L

ABEFJCGKDHLI

ADHIK L C G B F J E

ABFJDIECGKHL

General strategies:

Depth –first Breadth – first



1. If there are <u>critical sections</u> of the system, design the sequence such that these sections are added as early as possible

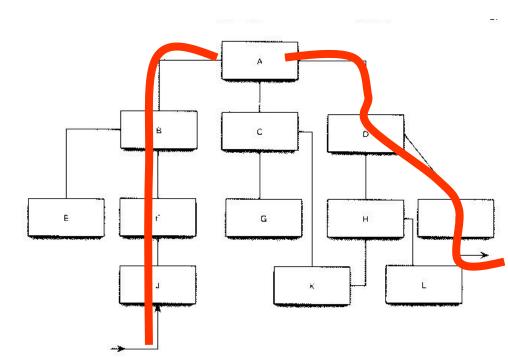
(critical – complex module, new algorithm, module that is suspected to have some faults, most frequently used...)

Top-down testing: two guidelines

2. Design the sequence such that the <u>I/O modules</u> are added as early as possible

For instance, as J, I are I/O modules, the sequence might be

ABFJD I C G E H K L





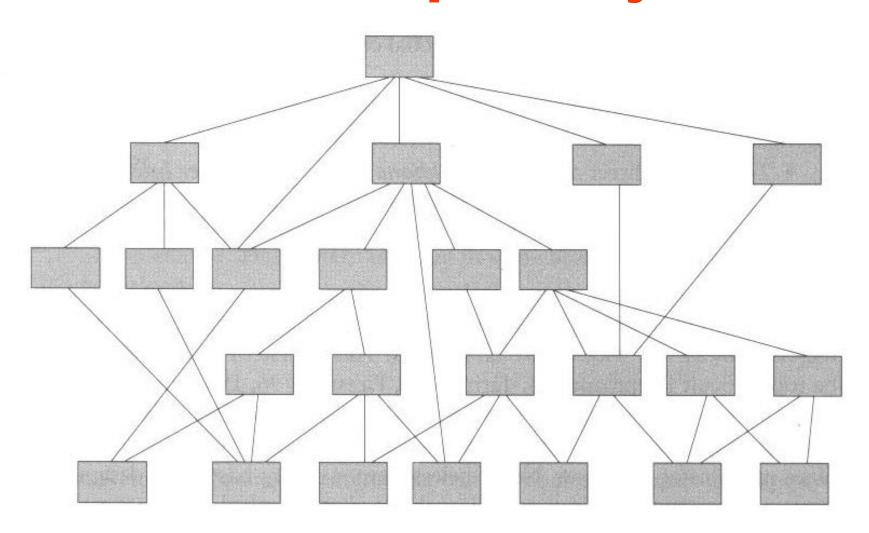
Skeleton of the entire system

Integration occurs quite early

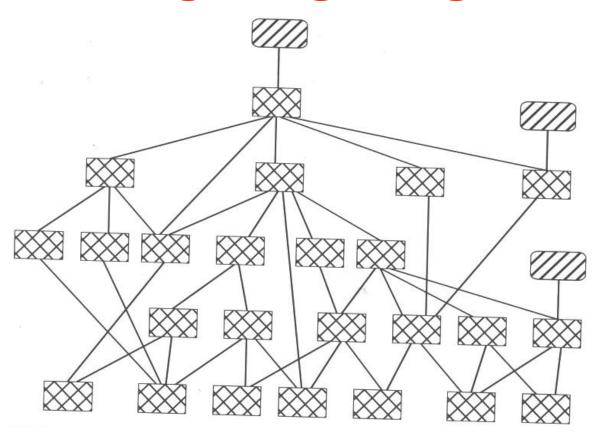
Time to working system is short

Difficulties in embedding test data in stub modules

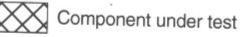
Modules and dependency tree



Big Bang Integration



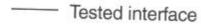




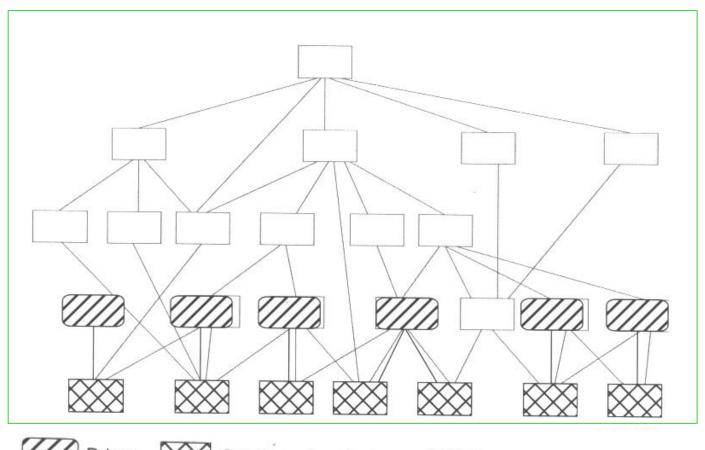








Bottom Up Integration (1)







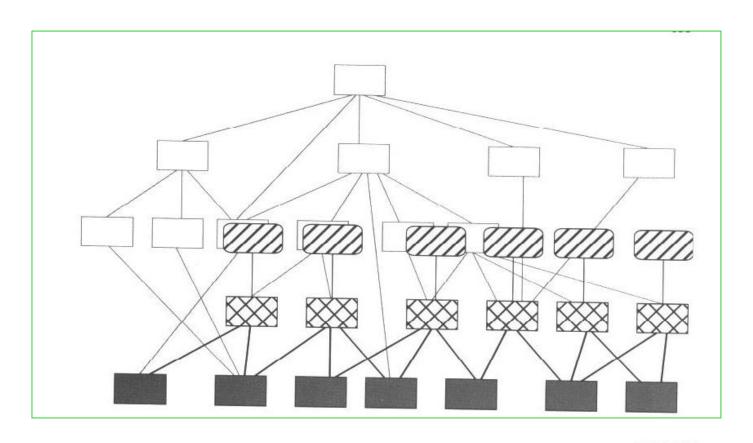


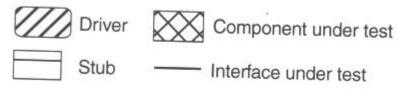




Tested interface

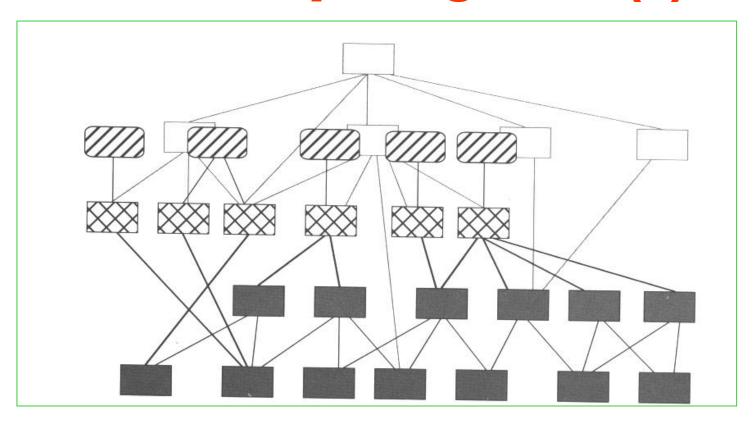
Bottom Up Integration (2)

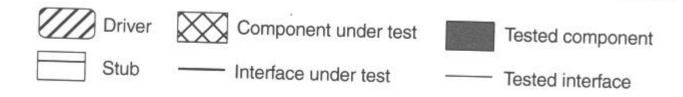




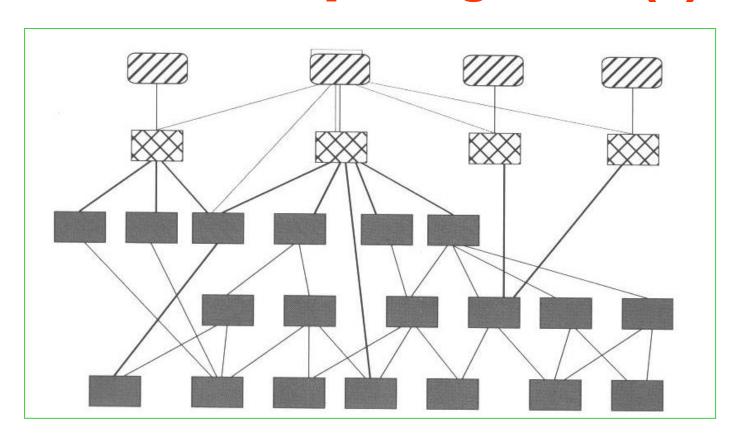


Bottom Up Integration (3)





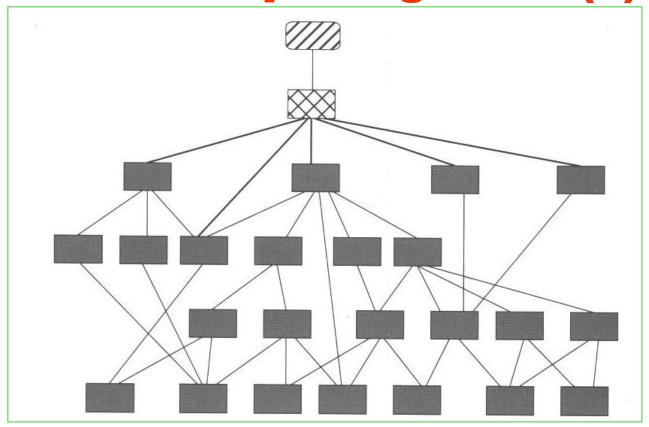
Bottom Up Integration (4)







Bottom Up Integration (5)







Component under test



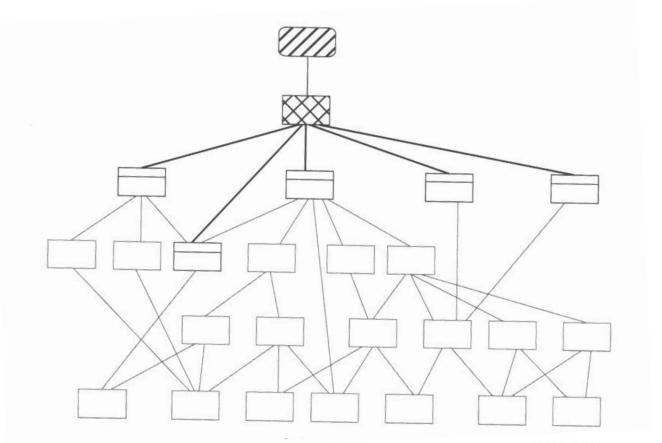
Tested component







Top-Down Integration (1)







Component under test



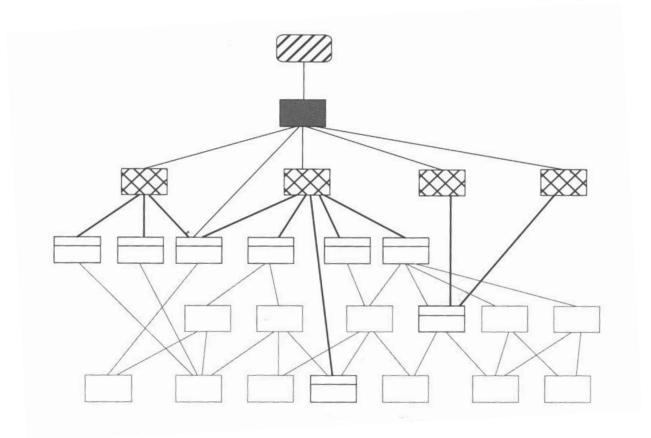
Tested component



Interface under test



Top-Down Integration (2)



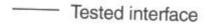




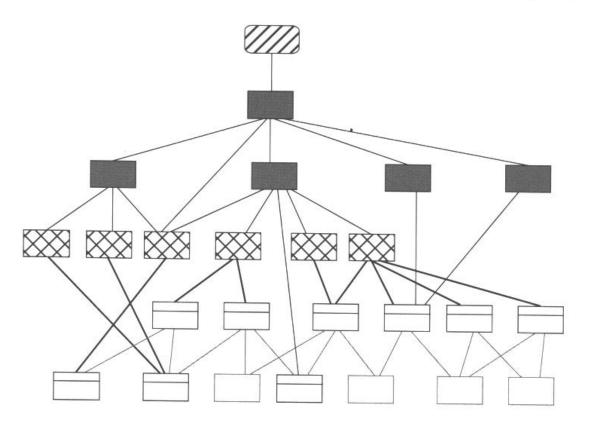


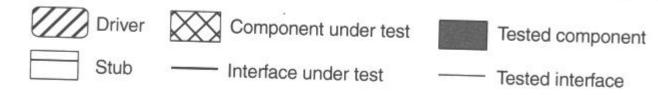




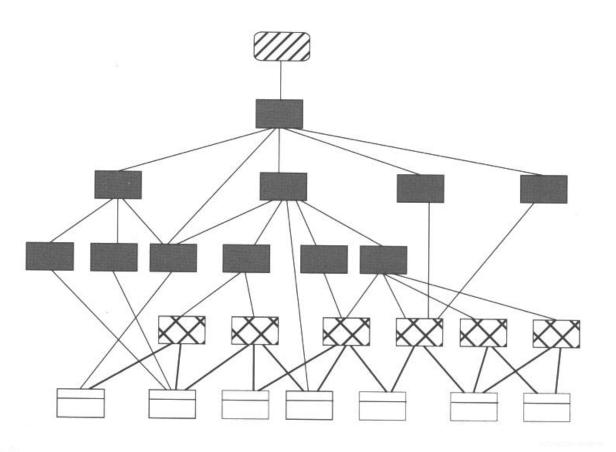


Top-Down Integration (3)





Top-Down Integration (4)







Component under test



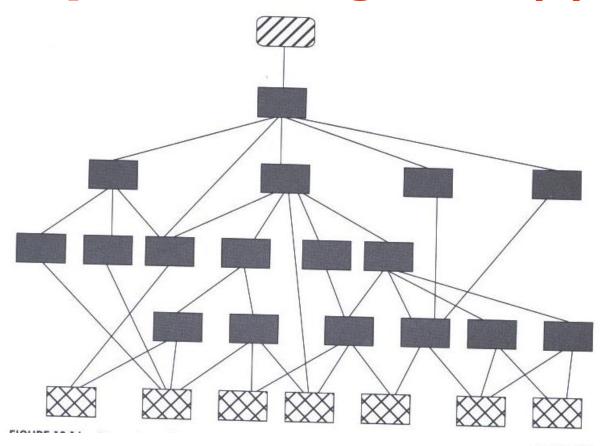
Tested component



Interface under test



Top-Down Integration (5)







Component under test



Tested component



Interface under test



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Top-down and bottom-up integration testing: a comparative overview (1)

Architecture validation

Top-down: more likely to discover faults in architecture at an early stage of the development

Bottom-up: high level design not validated until a late stage of the process

System demonstration

Top-down: limited, working system is available at an early stage

Bottom-up: late; if the system constructed from reusable components,

it may be possible to offer a similar demonstration



Test implementation

Top-down: development of stubs (simulating lower levels of system)

Bottom-up: development of drivers (simulation of components' environment)

Test observation

Both could have problems with test observation

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Sandwich Testing Strategy

Combines top-down strategy with bottom-up strategy

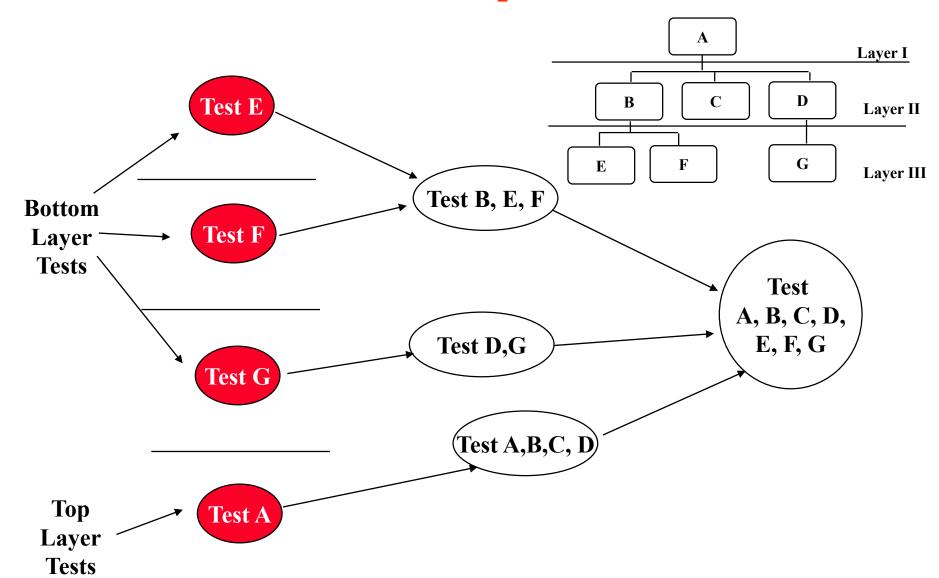
The system is viewed as having three layers

- □ A target layer in the middle
- □ A layer above the target
- □ A layer below the target
- □ Testing converges at the target layer

Selecting the target layer if there are more than three layers?

Heuristic: Try to minimize the number of stubs and drivers

Example-1



Advantages and Disadvantages of Sandwich Testing

Top and Bottom Layer Tests can be done in parallel

Does not test the individual subsystems thoroughly before integration

Modified Sandwich Testing

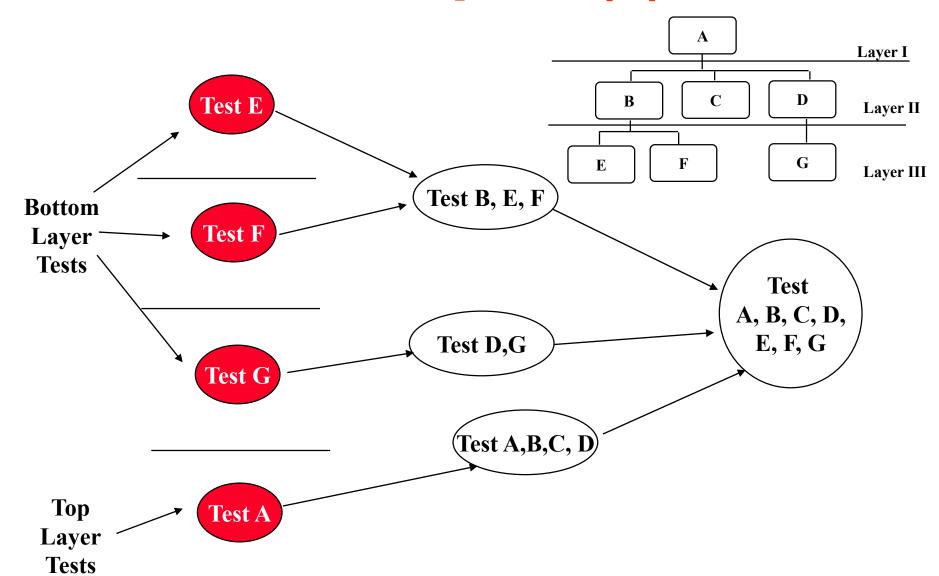
Test in parallel:

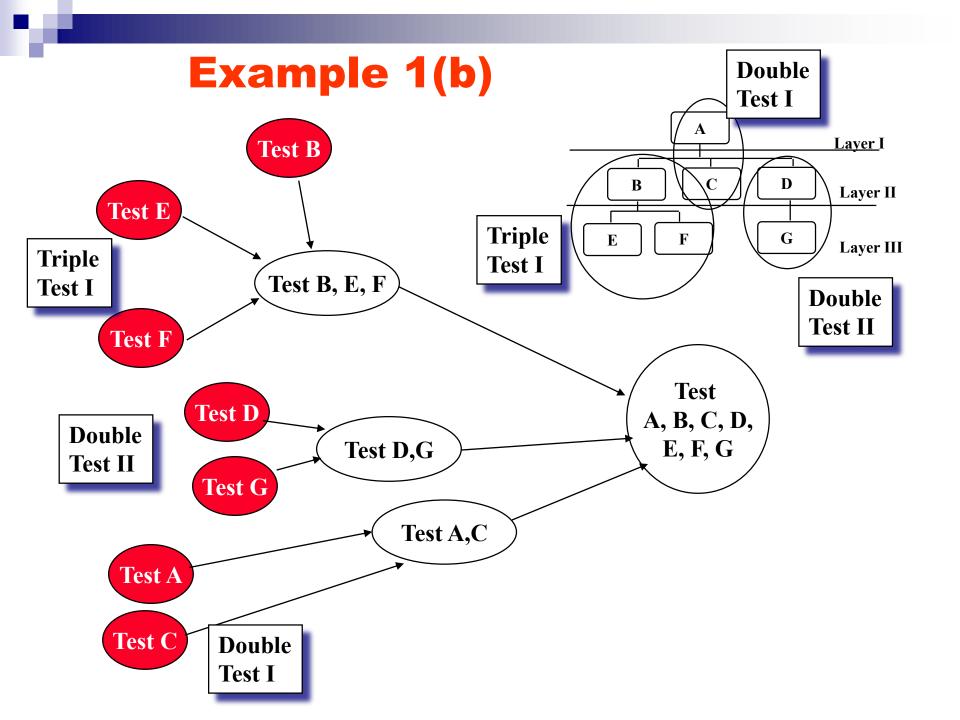
- Middle layer with drivers and stubs
- Top layer with stubs
- Bottom layer with drivers

Test in parallel:

- Top layer accessing middle layer (top layer replaces drivers)
- Bottom accessed by middle layer (bottom layer replaces stubs)

Example-1 (a)





Choosing an Integration Strategy

Factors to consider ☐ Amount of test harness (stubs &drivers) □ Location of critical parts in the system □ Availability of hardware ☐ Availability of components □ Scheduling concerns Bottom up approach good for object oriented design methodologies Test driver interfaces must match component interfaces

- ...Top-level components are usually important and cannot be neglected up to the end of testing
- Detection of design errors postponed until end of testing
- Top down approach
 - □ Test cases can be defined in terms of functions examined
 - □ Need to maintain correctness of test stubs
 - ☐ Writing stubs can be difficult



Choosing an Integration Strategy

Factors to consider

- □ Number of test harness (stubs &drivers)
- □ Location of critical parts in the system
- □ Availability and stability of components
- ☐ Scheduling concerns



Design reduction:

- start with a module control graph
- •remove all control structures that are not involved with module calls
- use "reduced" flow graph to realize integration testing

Develop a set of rules to perform design reduction

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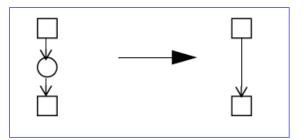
Design reduction – rules (1)

Eliminate parts of flow graph not involved with module calls



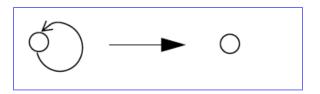
Call rule





2. Repetitive rule

eliminates test loops not involved with module calls

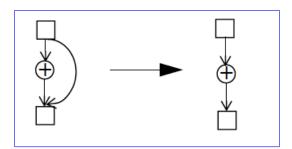




- \bullet = Call node \bigcirc = Non-call node
- \oplus = Path of zero or more non-call nodes
- \square = Any node, call or non-call

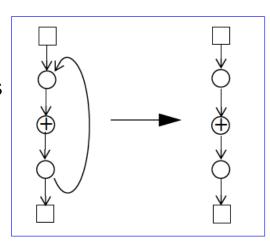
3. Conditional rule

eliminates conditional statements that do not contain calls in their bodies



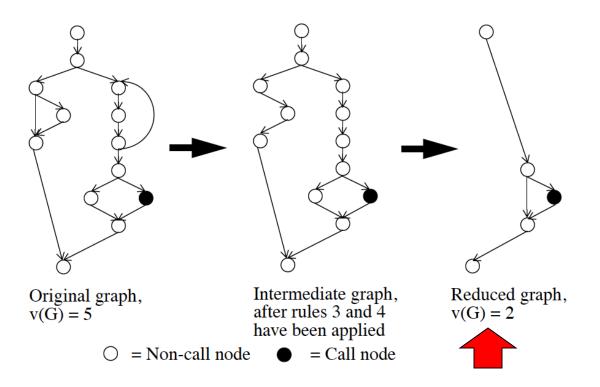
4. Looping rule

eliminates bottom test loops not involved with module calls



Design reduction – example

Apply the rules iteratively until non of them can be applied – design reduction has been completed



module design complexity iv(G) – cyclomatic complexity of the reduced graph

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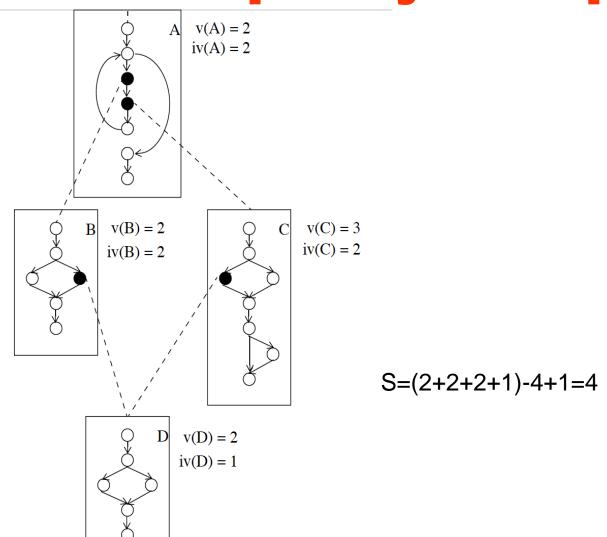
Integration complexity

N modules $(G_1, G_2, ..., G_n)$ with module design complexities $iv(G_1), iv(G_2), ..., iv(G_n)$

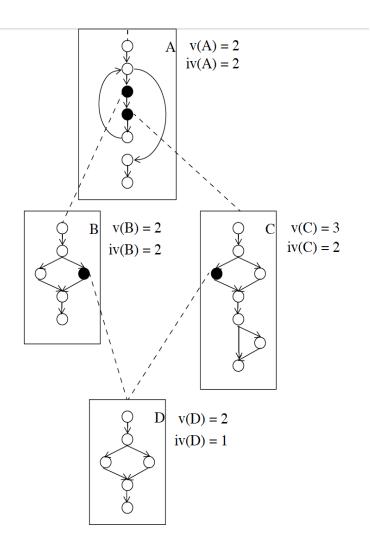
Integration complexity S: number of independent integration tests through a program design

$$S = \mathop{\text{a}}_{i=1}^{n} iv(G_i) - n + 1$$

Integration complexity-example



Integration complexity-example



Independent integration tests

 $X \rightarrow Y \leftarrow X$: X calls Y which returns to X

1.A

 $2.A \rightarrow B \leftarrow A \rightarrow C \leftarrow A$

 $3.A \rightarrow B \rightarrow D \leftarrow B \leftarrow A \rightarrow C \leftarrow A$

 $4.A \rightarrow B \leftarrow A \rightarrow C \rightarrow D \leftarrow C \leftarrow A$



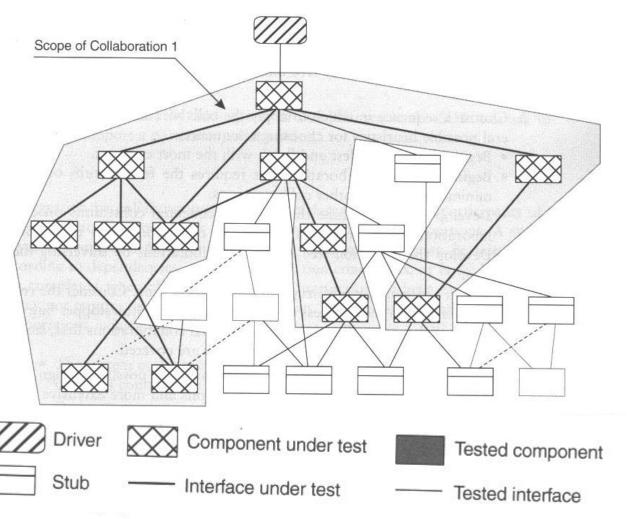
Collaboration integration

Existence of collaboration between participants

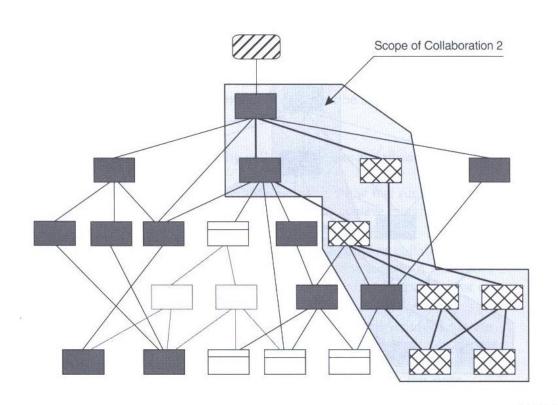
Sequence of collaborations (say, from simplest to more complex)

Participants in a collaboration are not exercised separately; a scenario-wise Big Bang integration

Collaboration Integration 1st configuration



Collaboration Integration 2nd configuration







Component under test



Tested component

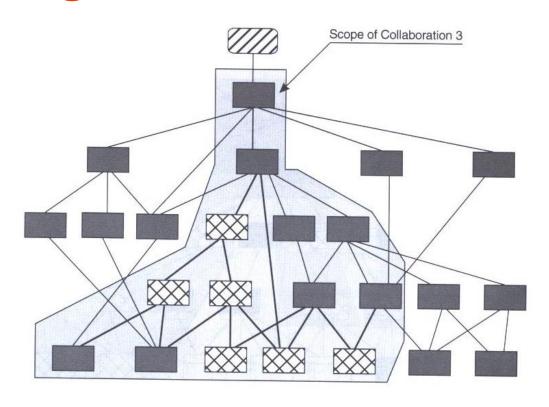


Stub

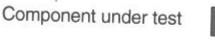
Interface under test



Collaboration Integration 3rd configuration







Tested component

Stub — Interface under test



Layer Integration

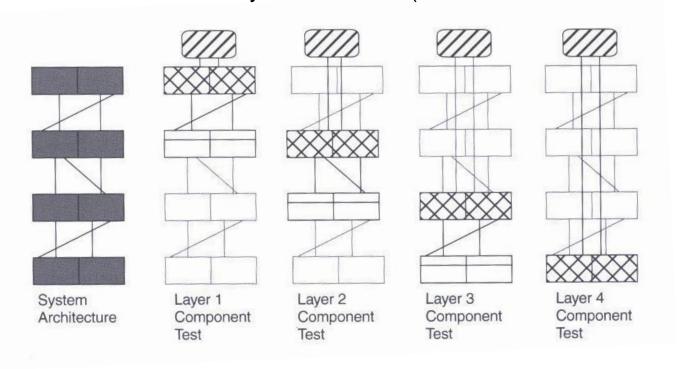
Incremental approach

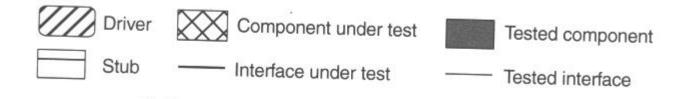
layered architecture modeled as a hierarchy that allows interfaces between adjacent layers

Layer integration may be top-down or bottom up

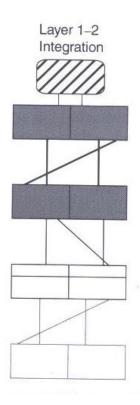
Layer integration (1)

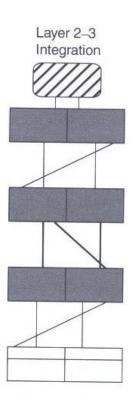
Test each layer in isolation (consider reusable drivers)

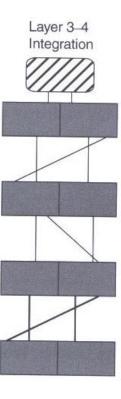




Layer integration (2)











Component under test



Tested component





Interface under test

